

RoHS Compliant Product  
 A suffix of "-C" specifies halogen and lead-free

**DESCRIPTION**

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low R<sub>DS(on)</sub> and to ensure minimal power loss and heat dissipation.

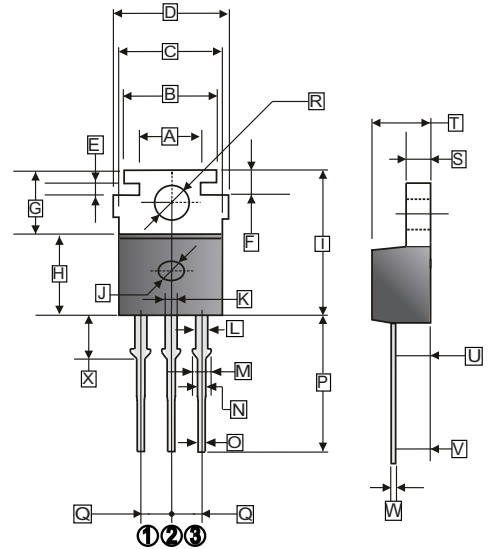
**TO-220P**

**FEATURES**

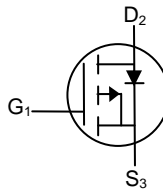
- Low R<sub>DS(on)</sub> provides higher efficiency and extends battery life.
- Low thermal impedance copper leadframe TO-220P saves board space.
- Fast Switch Speed.
- High performance trench technology.

**APPLICATION**

DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.



**P-Channel**



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	7.90	8.10	M	-	1.50
B	9.45	9.65	N	0.75	0.95
C	9.87	10.47	O	0.66	0.86
D	-	11.50	P	13.50	14.50
E	1.06	1.46	Q	2.44	3.44
F	2.60	3.00	R	3.50	3.70
G	6.30	6.70	S	1.15	1.45
H	8.35	8.75	T	4.30	4.70
I	14.7	15.3	U	-	2.7
J	1.60	Typ.	V	1.89	3.09
K	1.10	1.30	W	0.40	0.60
L	1.17	1.37	X	2.60	3.60

**ABSOLUTE MAXIMUM RATINGS** (T<sub>A</sub>=25°C unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	-60	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current <sup>1</sup>	I <sub>D</sub>	-90	A
Pulsed Drain Current <sup>2</sup>	I <sub>DM</sub>	-390	A
Continuous Source Current (Diode Conduction) <sup>1</sup>	I <sub>S</sub>	-110	A
Power Dissipation <sup>1</sup>	P <sub>D</sub>	300	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55~175	°C
<b>Thermal Resistance Rating</b>			
Maximum Junction to Ambient <sup>1</sup>	R <sub>θJA</sub>	62.5	°C / W
Maximum Junction to Case	R <sub>θJC</sub>	0.5	

Notes:

- 1 Package Limited.
- 2 Pulse width limited by maximum junction temperature.

**ELECTRICAL CHARACTERISTICS** ( $T_A=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Teat Conditions
<b>Static</b>						
Gate-Threshold Voltage	$V_{GS(th)}$	-1	-	-	V	$V_{DS}=V_{GS}$ , $I_D = -250\mu\text{A}$
Gate-Body Leakage	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{DS}=0$ , $V_{GS} = -20\text{V}$
Zero Gate Voltage Drain Current	$I_{DSS}$	-	-	-1	$\mu\text{A}$	$V_{DS} = -48\text{V}$ , $V_{GS}=0$
		-	-	-25		$V_{DS} = -48\text{V}$ , $V_{GS}=0$ , $T_J=55^\circ\text{C}$
On-State Drain Current <sup>1</sup>	$I_{D(on)}$	-120	-	-	A	$V_{DS} = -5\text{V}$ , $V_{GS} = -10\text{V}$
Drain-Source On-Resistance <sup>1</sup>	$R_{DS(ON)}$	-	-	12	m $\Omega$	$V_{GS} = -10\text{V}$ , $I_D = -2\text{A}$
		-	-	14		$V_{GS} = -4.5\text{V}$ , $I_D = -2\text{A}$
Forward Transconductance <sup>1</sup>	$g_{fs}$	-	30	-	S	$V_{DS} = -15\text{V}$ , $I_D = -2\text{A}$
Diode Forward Voltage	$V_{SD}$	-	-1.1	-	V	$I_S = -2\text{A}$ , $V_{GS}=0$
<b>Dynamic <sup>2</sup></b>						
Total Gate Charge	$Q_g$	-	100	-	nC	$V_{DS} = -15\text{V}$ , $V_{GS} = -4.5\text{V}$ , $I_D = -2\text{A}$
Gate-Source Charge	$Q_{gs}$	-	30	-		
Gate-Drain Charge	$Q_{gd}$	-	40	-		
Turn-on Delay Time	$T_{d(on)}$	-	20	-	nS	$V_{DD} = -25\text{V}$ , $V_{GEN} = -10\text{V}$ , $R_L = 25\Omega$ , $I_D = -34\text{A}$
Rise Time	$T_r$	-	20	-		
Turn-off Delay Time	$T_{d(off)}$	-	300	-		
Fall Time	$T_f$	-	100	-		

Notes:

- 1 Pulse test :  $PW \leq 300 \mu\text{s}$  duty cycle  $\leq 2\%$ .
- 2 Guaranteed by design, not subject to production testing.